
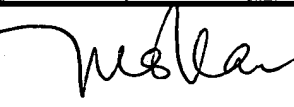
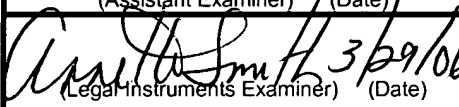


<b>Issue Classification</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/815,162	WU, STEPHEN	
	Examiner	Art Unit	
	Hiep Nguyen	2816	

ISSUE CLASSIFICATION										
ORIGINAL				CROSS REFERENCE(S)						
CLASS	SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
327	156			327	157	117				
INTERNATIONAL CLASSIFICATION										
40	3	L	7100							
			/							
			/							
			/							
			/							

HIEP NGUYEN 03.16.06 (Assistant Examiner) (Date)		 TUAN T. LAM PRIMARY EXAMINER (Primary Examiner)		Total Claims Allowed: 31	
 ANITA SMITH 3/29/06 (Legal Instruments Examiner) (Date)		3/29/06 (Date)		O.G. Print Claim(s) 1	
				O.G. Print Fig. 3	

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
1	1						
2	2						
3	3	29	32				
4	4	30	33				
5	5	31	34				
6	6		35				
7	7						
8	8						
9	9						
10	10						
11	11						
12	12						
13	13						
14	14						
15	15						
16	16						
17	17						
18	18						
19	19						
20	20						
21	21						
22	22						
23	23						
24	24						
25	25						
26	26						
27	27						
28	28						
29	29						
30	30						
31	31						